International Standard

ISO/IEC 17760-105

First edition
2024-03

Information technology — AT Attachment —

Part 105:
ATA Command Set - 5 (ACS-5)”

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Reference number
ISO/IEC 17760-105:2024(en)

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Published in Switzerland

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This document was prepared by INCITS (as INCITS 558-2021, ATA Command Set – 5) and drafted in accordance with its editorial rules. It was assigned to Joint Technical Committee ISO/IEC JTC 1, *Information technology*, and adopted under the "fast-track procedure".

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